

Methods for characterization and correction of transducer response in presence of actual MV distorted waveforms

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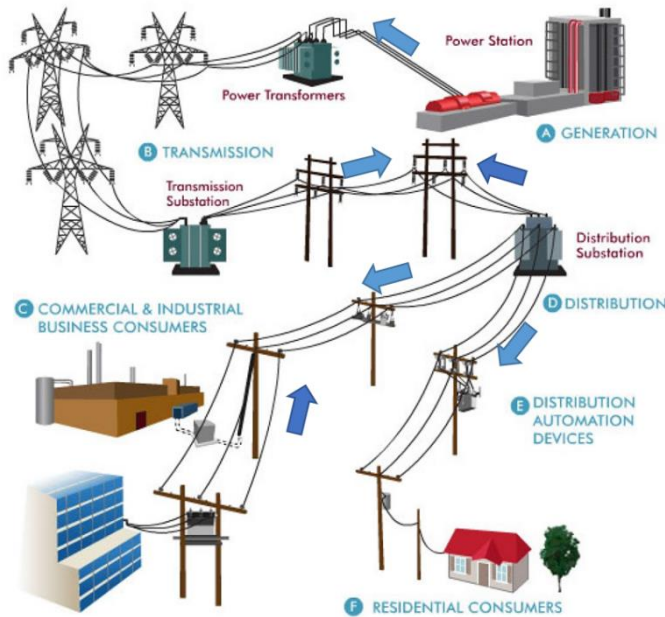
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Outline

- ✓ **Rationale and scope**
- ✓ **Circuits for frequency response characterization of MV voltage measurement transformer**
- ✓ **Method for the real-time compensation of voltage transducer frequency response**
- ✓ **Experimental validation**
- **Discussion and conclusions**

Motivation

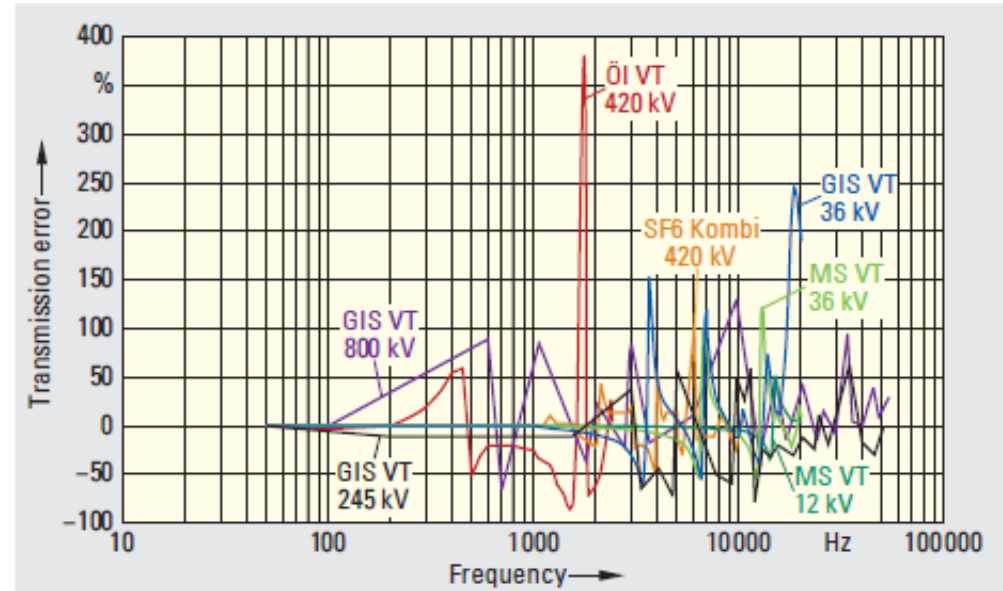
Use of power electronic devices and DG from renewable is modifying the transmission and distribution grid conditions with reference both to power flow and its quality



- ✓ Information from PMUs and knowledge of the quality of the transferred power play a basic role in ensuring accurate evaluation of grid state

Motivation

- ✓ Used instrument transformers do not always accurately scale and input to the PMU/PQ measuring instrument the voltage/current levels



K. Kunde et al., Components & Periphery 3 Heft 6/2012, ETZ

- ✓ Need for the use of most accurate, extended performances transducers with reference to the on-site measurement conditions.

Smart Grid II...

- ✓ Optimization of performances of non-invasive current transducers
- ✓ Voltage transformers (VTs) calibration systems for determining frequency response at rated voltage
- ✓ Methods for real time compensation of voltage transducer frequency response
- ✓ Modelling for the uncertainty propagation through the PMU/PQ measurement chain

Calibration set-up requirements

Generation of realistic distorted voltages (fundamental at rated voltage with superimposed harmonics/interharmonics/subharmonics,...).

Operating frequency range:

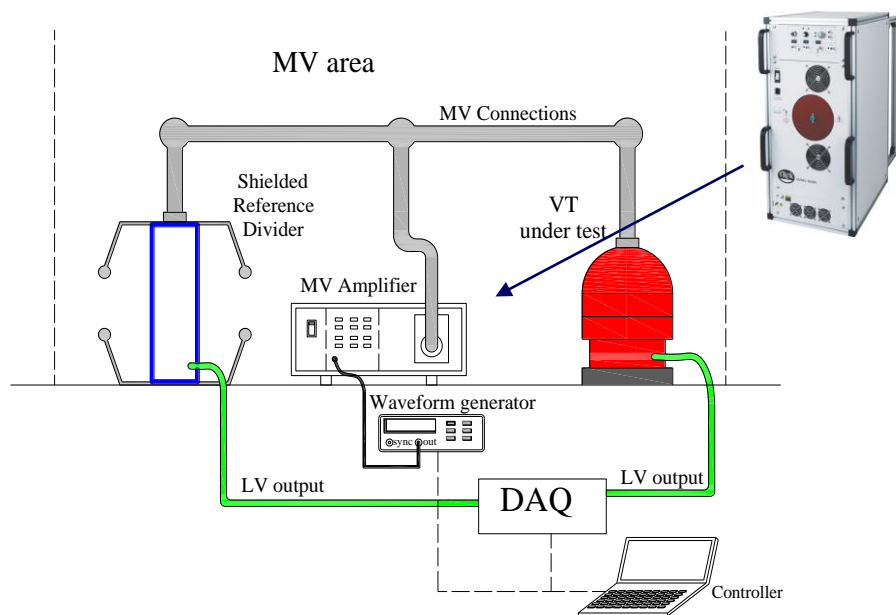
up to the 50th harmonic (minimum requirement)

Traceable measurement of ratio and phase errors

Uncertainty: two orders of magnitude better the indicated accuracy limits for VTs in PQ measurements (IEC 60044-8)

Calibration circuit layout:

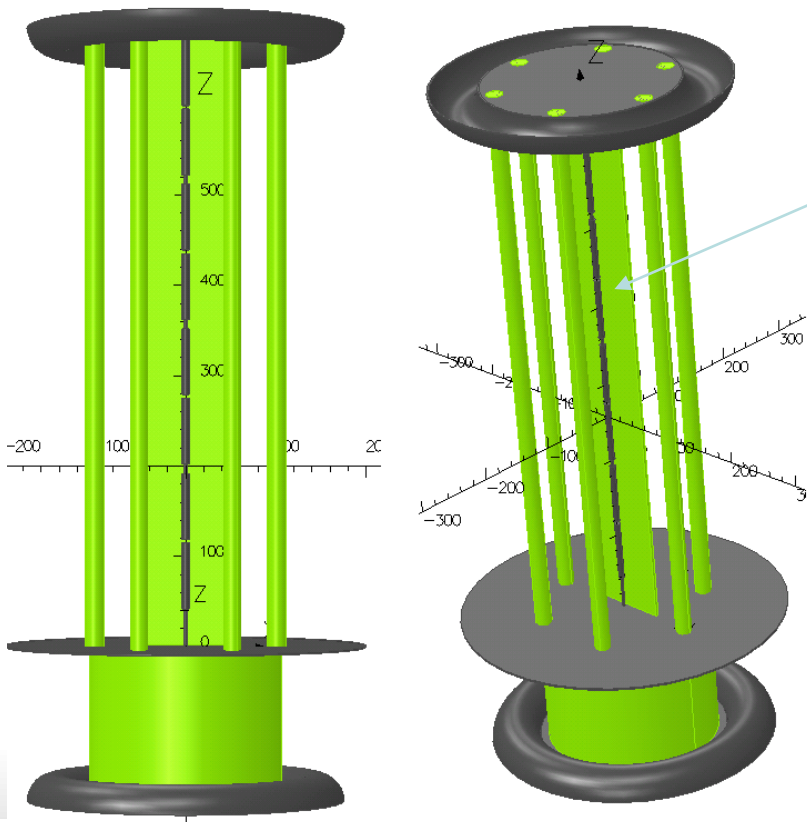
i) Comparison with a reference voltage transducer



Supply:
Arbitrary Waveform Generator
+ MV Amplifier
(+ step-up transformer)

Measurement:
Reference divider
DAQ system (Agilent 3458/NI)

30 kV Compensated reference resistive divider



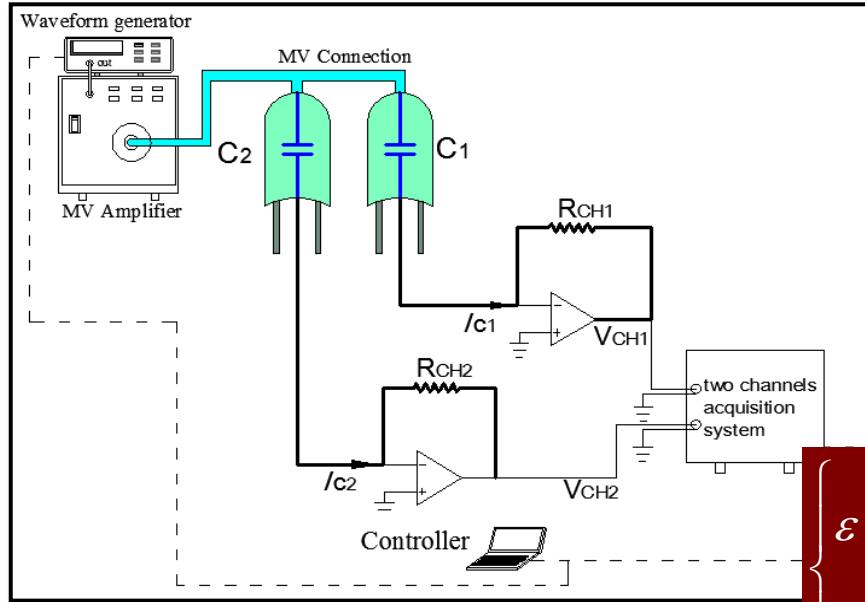
DC to 30 kHz
Ratio error variation $< 2 \cdot 10^{-4}$

Phase error $< 110 \mu\text{rad}$
(with compensation stage)

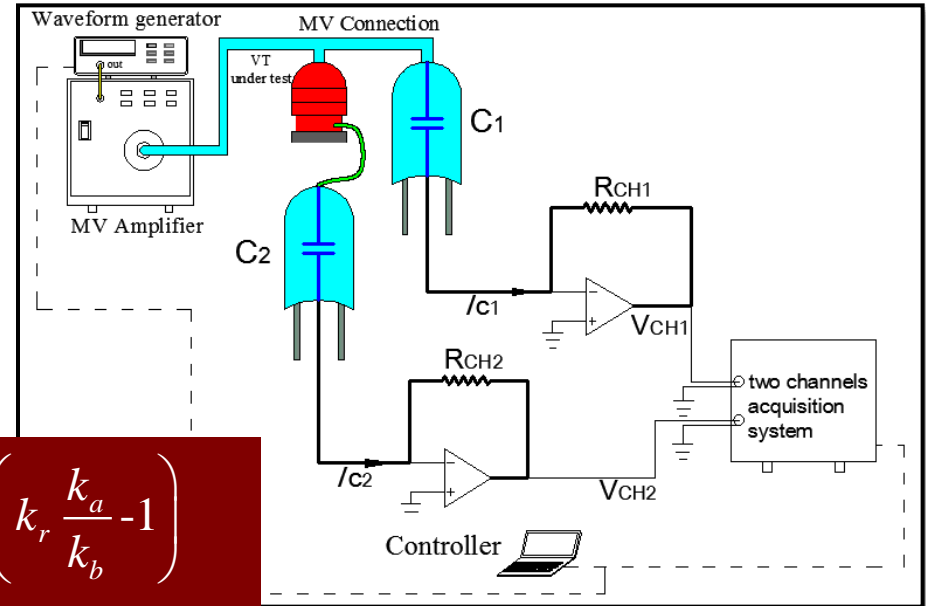
Calibration circuit layout:

ii) Calibration by HV capacitance bridge

► First step (a)



► Second step (b)



$$\left\{ \begin{array}{l} \varepsilon = \left(k_r \frac{k_a}{k_b} - 1 \right) \\ \Delta \eta = \Delta \varphi|_b - \Delta \varphi|_a \end{array} \right.$$

Output:
$$\left\{ \begin{array}{l} k_a = \frac{|V_{CH1}|}{|V_{CH2}|} \\ \Delta \varphi|_a = \varphi(V_{CH2}) - \varphi(V_{CH1}) \end{array} \right.$$

Output:
$$\left\{ \begin{array}{l} k_b = \frac{|V_{CH1}|}{|V_{CH2}|} \\ \Delta \varphi|_b = \varphi(V_{CH2}) - \varphi(V_{CH1}) \end{array} \right.$$

Ideal conditions:

Supply voltage linearity of C_2 and R_{CH2} under step a) and b) conditions

No loading effect of C_2 on the VT under calibration

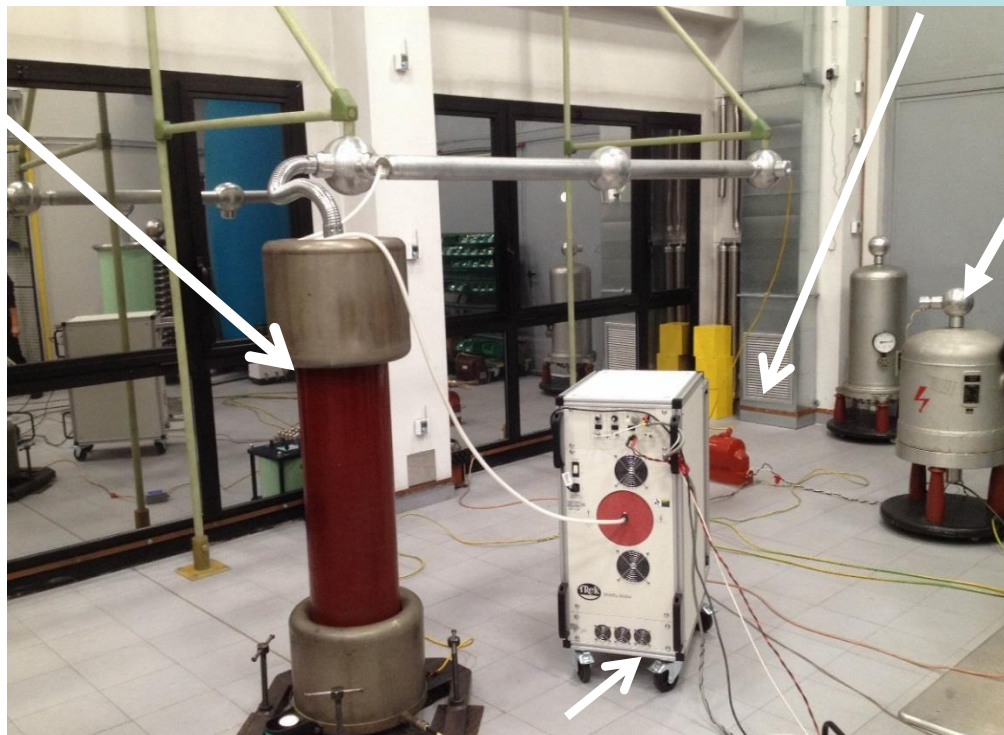


$$G_{VT}(f) \cdot e^{i\phi_{VT}(f)} = \frac{(V_{CH1}/V_{CH2})_a}{(V_{CH1}/V_{CH2})_b}$$

Quantity/ influence factor	Standard Uncertainty	Evaluation method
C2 non linearity (up to 40 kV, 50 Hz): Capacitance Dissipation factor	$< 2 \cdot 10^{-5}$ $< 1 \mu\text{rad}$	Comparison with a 700 kV capacitor
C2 loading effect (50 Hz to 2.5 kHz): ratio error phase error	negligible up to 1 kHz 400 $\mu\text{V}/\text{V}$ at 2.5 kHz $< 10 \mu\text{rad}$	Computation and measurements on a 20 kV/100 V VT
Digitizer ($V_{CH1}=V_{CH2}$) (50 Hz to 3 kHz) Ratio error: Phase error:	20 ppm to 40 ppm 2 μrad to 30 μrad	Generation of known signals
Digitizer ($V_{CH1}=100 \cdot V_{CH2}$) (50 Hz to 3 kHz) Ratio error: Phase error:	30 ppm to 100 ppm 4 μrad to 100 μrad	Generation of known signals of different amplitudes

Calibration of a 20 kV/ $\sqrt{3}$ VT

VT under test

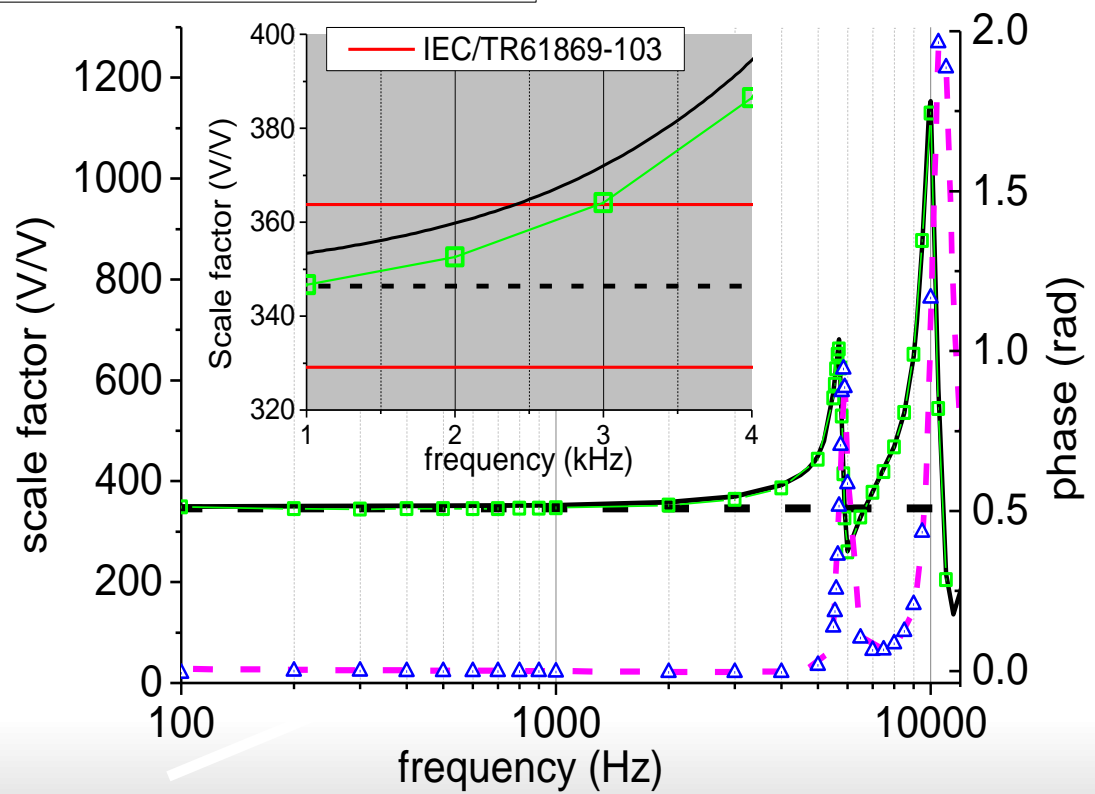
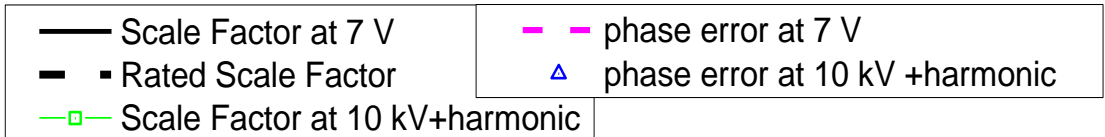


Compressed gas capacitor C₁
Max voltage: 200 kV
C₁: 103.54 pF
tan δ : $1 \cdot 10^{-5}$

Compressed gas capacitor C₂
Max voltage: 60 kV
C₂: 1.0467 nF
tan δ : $1 \cdot 10^{-5}$

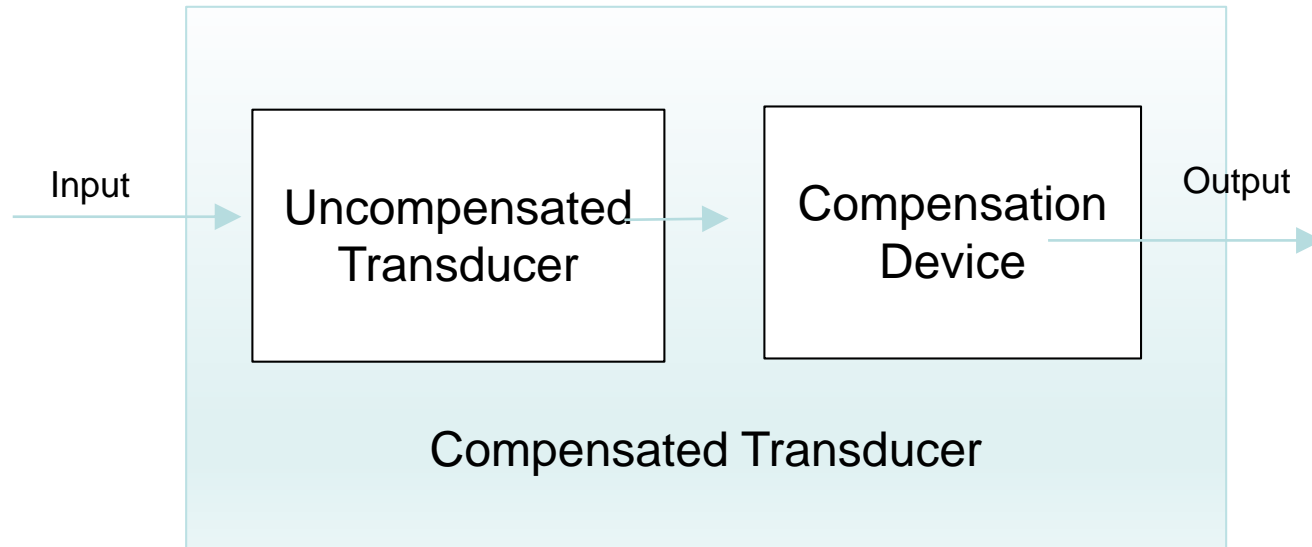
MV amplifier (30 kV_p, 20 mA)

Frequency response of a 20 kV/ $\sqrt{3}$ /100 V VT



Transducer error compensation

Once errors are known, they can be corrected cascading to the transducer a compensation device

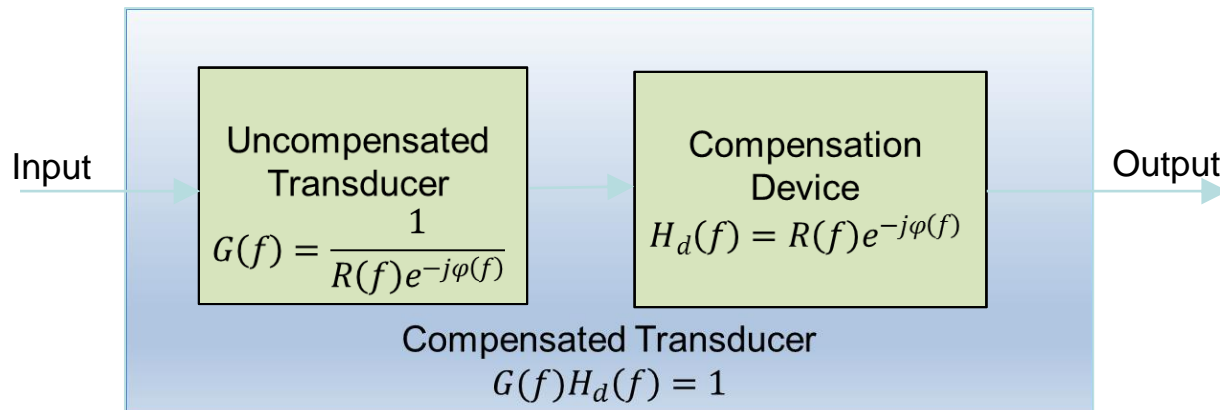


Working hypotheses for of compensation of VTs and CTs

➤ Linearity of transducer

Voltage measurement transformer assumed linear from 80% to 120% of rated voltage and with high impedance load.

...the compensation device should implement transducer inverse frequency response!



Compensation through a filter

- Analog implementation drawbacks
 - acceptable results only on a very limited range of frequencies
 - inherent variability of the physical components (resistors, inductors, and capacitors)
 - rigidity of the compensator that is not reconfigurable except by replacement of hardware components, preventing the possibility of real-time changes (non-adaptive filters)
- Digital implementation drawbacks
 - time discretization of the input variables;
 - numerical quantization, that is amplitude discretization of the input variables;
 - delay of execution

Filter function identification

- 1) Measurement of the transducer frequency response in N_f points ($H_d(f_i) = V_{LV}(f_i) / V_{HV}(f_i)$)
- 2) Modelling of an infinite impulse response filter (IIR), as a product of N Second Order Sections:

$$H(z) = K \prod_{k=1}^N \frac{1 + b_{1,k} z^{-1} + b_{2,k} z^{-2}}{1 + a_{1,k} z^{-1} + a_{2,k} z^{-2}}$$

- 3) Identification of the $4 \cdot N + 1$ filter coefficients (\mathbf{P}), by minimizing the objective function $\mathbf{C}(\mathbf{P})$:

$$\mathbf{C}(\mathbf{P}) = \frac{1}{2} \sum_{i=1}^M W(f_i) \cdot \left[\log_{10} \frac{H(f_i, \mathbf{P})}{H_d(f_i)} \right]^2 \cdot \left[\log_{10} \frac{f_{i+1}}{f_{i-1}} \right] \quad \mathbf{W}(f_i) = \text{weight}$$

Settings of the optimization algorithm

1. Choose the weights of the objective function

- Weights have influence on the algorithm performance

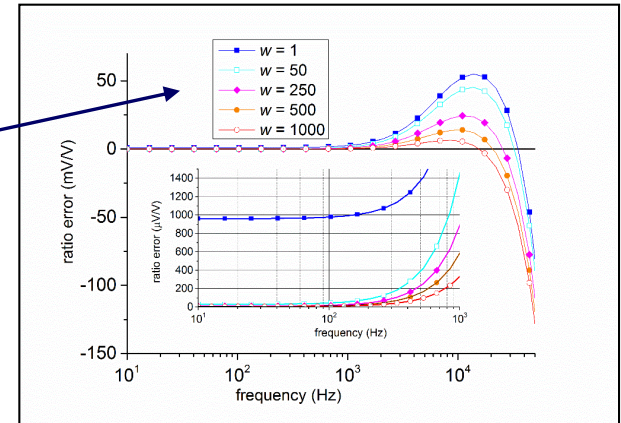
2. Choose a range for number of SOS (e.g. 1 to 10)

- Typically, higher filter orders reach better compensation performance but higher order means slower convergence of the optimization algorithm and higher computational burden for real-time filter execution

3. Choose a number of iterations for every SOS

- Since the algorithm has a stochastic section, two identical runs give different results

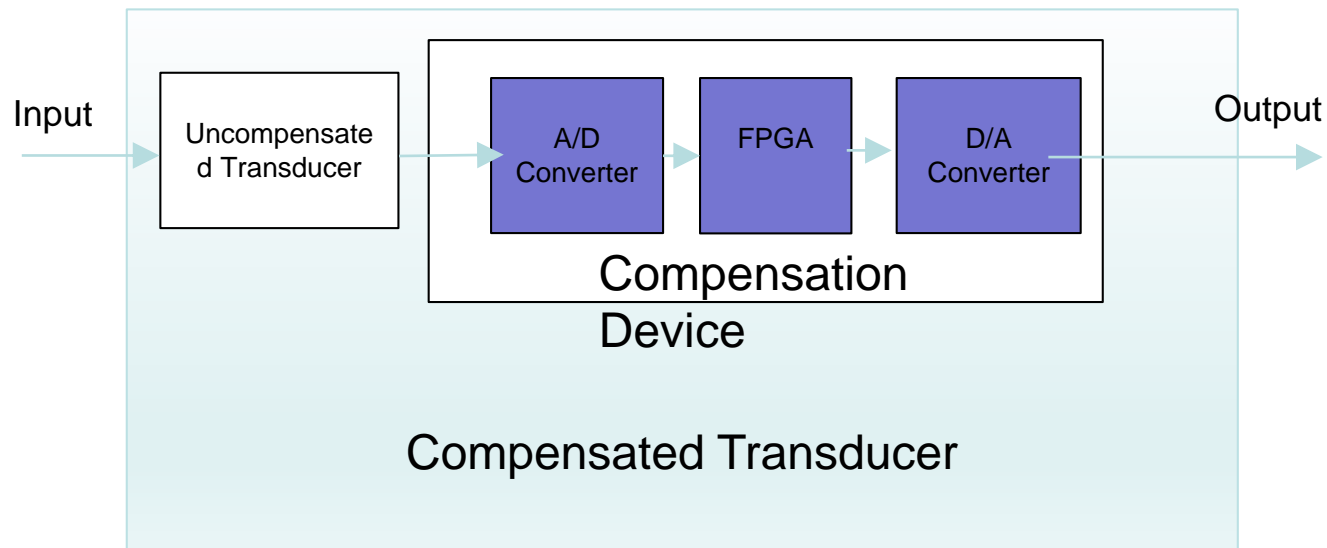
4. Choose performance indexes to evaluate results of optimization algorithms



$$I_R = \frac{\overline{\Delta R^2}}{\Delta R_C^2} = \frac{\sqrt{\frac{1}{N_f} \sum_{k=1}^{N_f} [\Delta R(f_k)]^2}}{\sqrt{\frac{1}{N_f} \sum_{k=1}^{N_f} [\Delta R_C(f_k)]^2}}$$

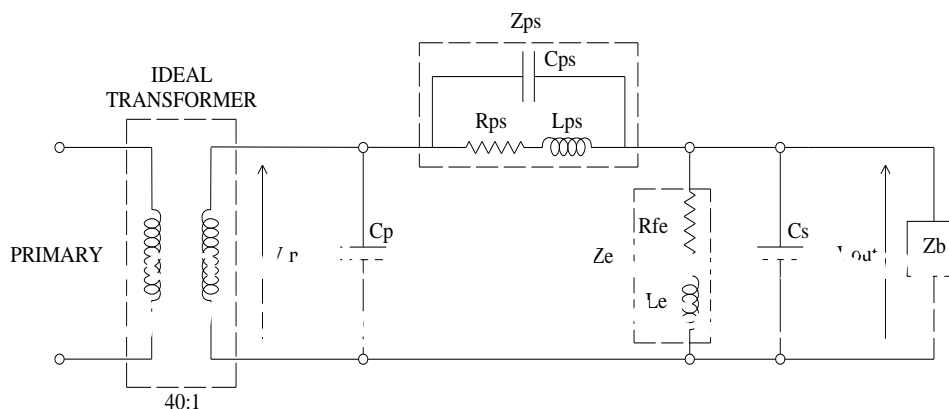
$$I_\varphi = \frac{\overline{\Delta \varphi^2}}{\Delta \varphi_c^2} = \frac{\sqrt{\frac{1}{N_f} \sum_{k=1}^{N_f} [\Delta \varphi(f_k)]^2}}{\sqrt{\frac{1}{N_f} \sum_{k=1}^{N_f} [\Delta \varphi_c(f_k)]^2}}$$

Compensation with Real-Time Digital Signal Processing



FPGA implements the **DIGITAL FILTER**

Model of a Voltage Measurement Transformer

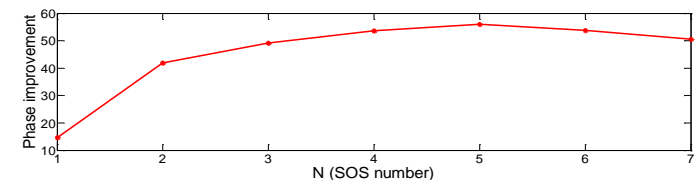
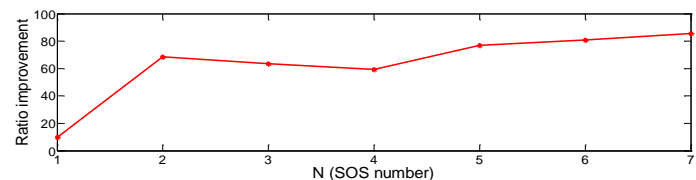
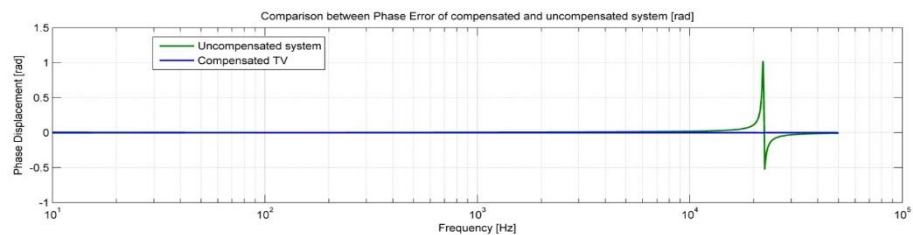
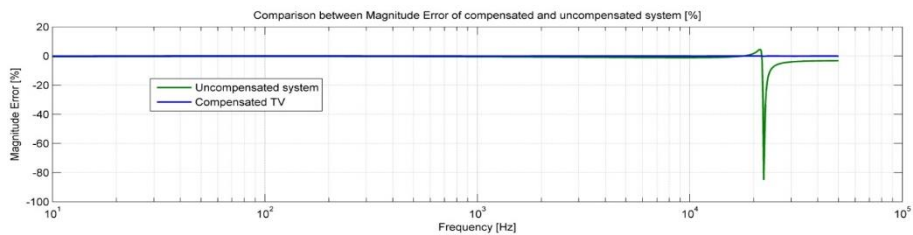


VT ratings: 4800 V primary, 40:1 turns ratio, ANSI accuracy class 0.3, 120 V secondary output rated frequency 60 Hz.

Circuit parameters: $C_p = 160$ nF, $R_{ps} = 1$ Ω , $L_{ps} = 1.7$ mH, $C_{ps} = 30$ nF, $R_{fe} = 35\sqrt{f}$ Ω , $L_e = \frac{5.6}{\sqrt{f}}$ mH, $C_s = 1$ nF, $Z_b = 1$ M Ω .

Compensation of simulated VT response

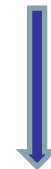
weights: $f < 100 \text{ Hz}$ $w = 5000$ $100 \text{ Hz} < f < 2500 \text{ Hz}$ $w = 2000$ $f > 2500 \text{ Hz}$ $w = 1000 \text{ Hz}$



freq [Hz]	Ratio error [%]		Phase displacement [mrad]	
	Comp	Uncomp	Comp	Uncomp
50	0,0613	-0,3072	1,1639	-0,9456
100	0,0754	-0,2939	0,3522	0,0824
1000	-0,0747	-0,5217	-0,2232	4,3203
10000	0,0505	-1,1063	-0,5056	18,7441
20000	0,0293	1,7130	-1,0460	111,1353
22275	-0,9256	-84,9464	-6,7732	557,7878
50000	-0,0621	-3,2076	1,2385	-8,2199

Application to the compensation of a 1 kV VT response

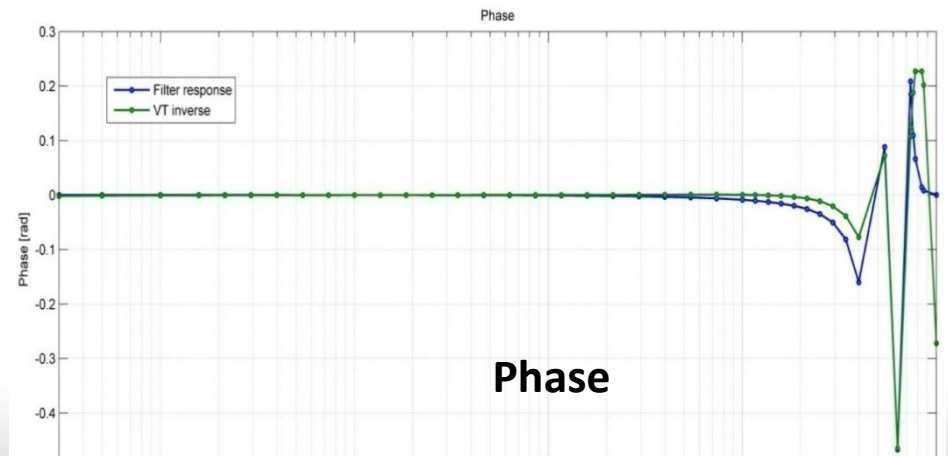
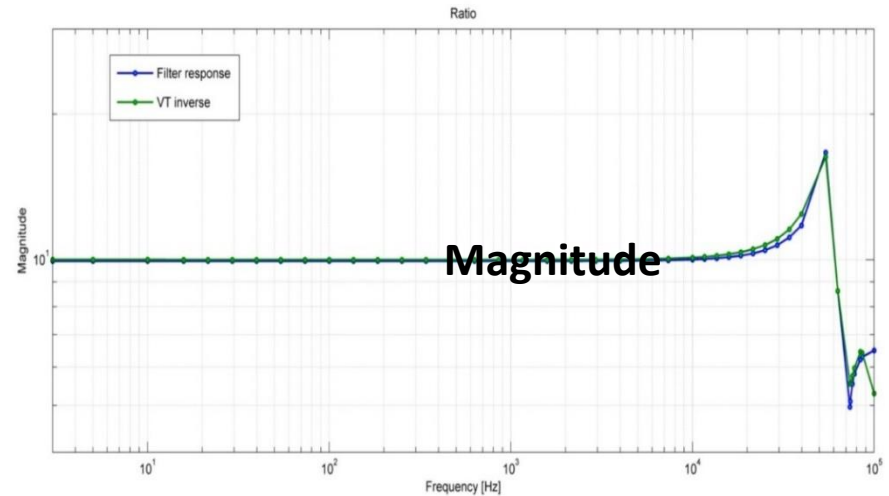
1. Fluke 5500A calibrator
2. DAQ board, 4 synchronous 16 bit inputs, ± 10 V, maximum sampling rate 1 MHz
3. Application of sinusoidal signals from 3 Hz to 250 kHz:
 - 7 V up to 100 kHz
 - 3 V above 100 kHz
4. Acquisition and elaboration software in Python



1 kV/100 V VT

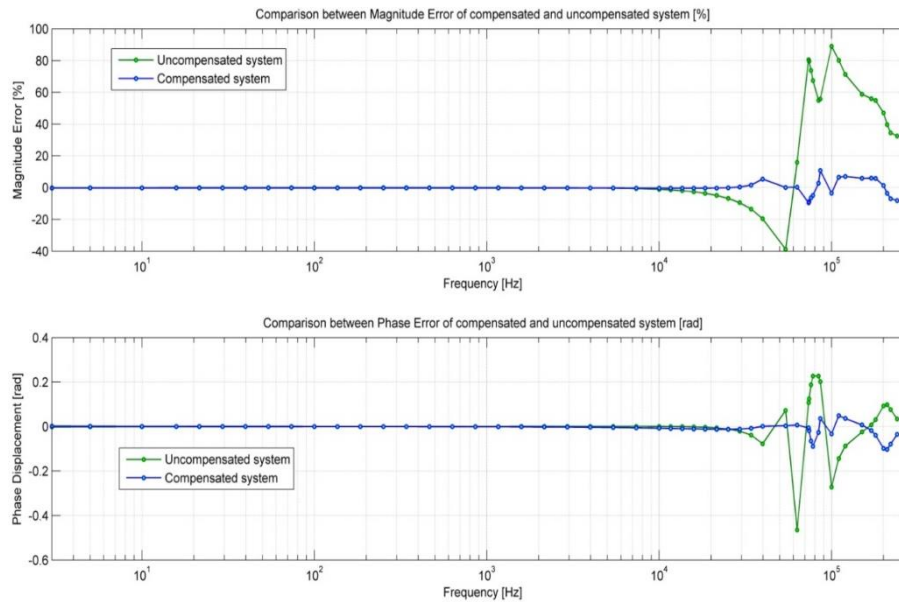
MatLab implementation of digital filter (1)

First resonance frequency
Comparison measured and
inverse computed frequency
response



MatLab implementation of digital filter (2)

Compensated and uncompensated system



Experimental characterization of FPGA compensated VT

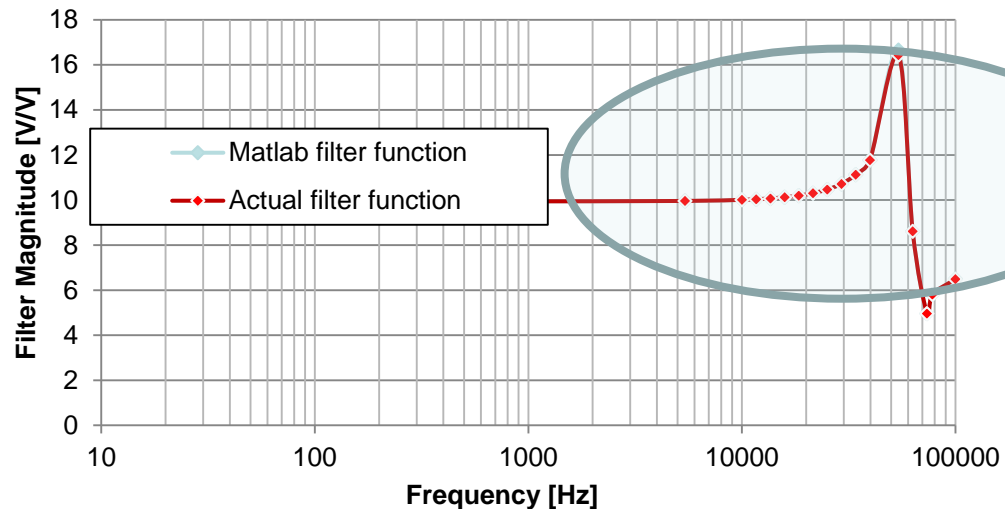
1. Fluke 5500a calibrator
2. DAQ board

NI CompactRIO: AC signals 3 Hz to 250 kHz:

- a. 7 V up to 100 kHz
- b. 3 V above 100 kHz.

1. Software: **LabVIEW FPGA**

Comparison between theoretical and actual magnitude filter response



Conclusions

- ❑ Systems for the measurement of frequency response of MV VTs are being experimented with distorted waveform up to some ten kilohertz.
- ❑ Method for the real-time compensation of voltage transducer frequency response by digital filter have been developed.

Next steps

- Extension of the VT characterization up to 30 kV
- Investigation on frequency response of VT of the same type as those operating in MV substations
- Implementation of the real time compensation procedure
- Compensation of the unsatisfactory response of VTs
- Provide input data to the model for the propagation of the uncertainty through the PMU/PQ measurement chain